

Power MOSFET

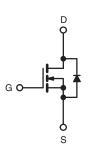
PRODUCT SUMMARY						
V _{DS} (V)	200	200				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.80				
Q _g (Max.) (nC)	14	14				
Q _{gs} (nC)	3.0	3.0				
Q _{gd} (nC)	7.9					
Configuration	Sing	Single				

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC







N-Channel MOSFET

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	200		
Gate-Source Voltage			V _{GS}	± 20	V	
Continuous Drain Current	V _{GS} at 10 V	T _A = 25 °C		0.80	А	
Continuous Drain Current		T _A = 100 °C	ID	0.50		
Pulsed Drain Current ^a			I _{DM}	6.4	1	
Linear Derating Factor				0.0083	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	260	mJ	
Repetitive Avalanche Current ^a			I _{AR}	5.2	Α	
Repetitive Avalanche Energy ^a			E _{AR}	0.10	mJ	
Maximum Power Dissipation	T _A = 25 °C		P _D	1.0	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	7	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 152 mH, R_g = 25 Ω , I_{AS} = 1.6 A (see fig. 12).
- c. $I_{SD} \le 5.2$ A, $dI/dt \le 95$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R_{thJA}	-	120	°C/W		

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.29	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V	-	-	± 100	nA
Zava Cata Valtaga Dvain Cuwant	I _{DSS}	V _{DS} = 200 V, V _{GS} = 0 V		-	-	25	μΑ
Zero Gate Voltage Drain Current		V _{DS} = 160 V, V _{GS} = 0 V, T _J = 125 °C		-	-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 0.48 A ^b	-	0.80	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 50 V, I _D = 0.48 A ^b		0.60	-	-	S
Dynamic							
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V,		-	260	-	
Output Capacitance	Coss			-	100	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1	0 MHz, see fig. 5	-	30	-	
Total Gate Charge	Qg			-	-	14	
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 4.8 \text{ A}, V_{DS} = 160 \text{ V},$ see fig.6 and 13 ^b		-	3.0	nC
Gate-Drain Charge	Q_{gd}		goo ngio ana io	-	-	7.9	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 100 V, I_{D} = 4.8 A, R_{g} = 18 Ω , R_{D} = 19 Ω , see fig. 10 ^b		-	7.2	-	- ns
Rise Time	t _r			-	22	-	
Turn-Off Delay Time	t _{d(off)}			-	19	-	
Fall Time	t _f			-	13	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.0	-	- nH
Internal Source Inductance	L _S			-	6.0	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	0.80	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	6.4	
Body Diode Voltage	V_{SD}	T _J = 25 °C	$I_S = 0.80 \text{ A}, V_{GS} = 0 \text{ V}^b$	-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T _ 05 °C !	_ 4 0 A dI/d+ 400 A /:-h	-	150	300	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 4.8 \text{A}, dI/dt = 100 \text{A/} \mu \text{s}^{\text{b}}$		-	0.91	1.8	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time is negligible (turn	on is dor	ninated b	y L _S and	L _D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

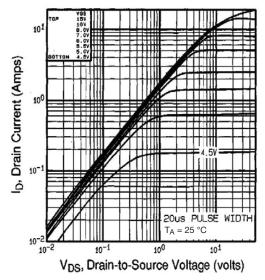


Fig. 1 - Typical Output Characteristics, T_A = 25 °C

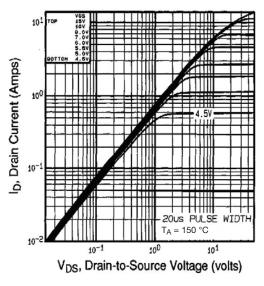


Fig. 2 - Typical Output Characteristics, T_A = 150 °C

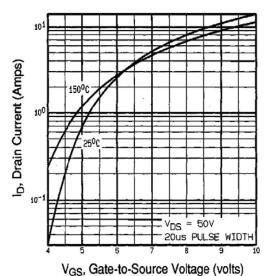


Fig. 3 - Typical Transfer Characteristics

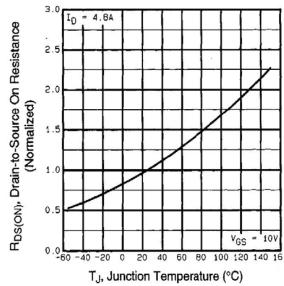


Fig. 4 - Normalized On-Resistance vs. Temperature



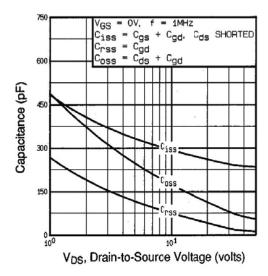


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

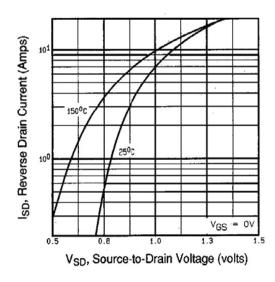


Fig. 7 - Typical Source-Drain Diode Forward Voltage

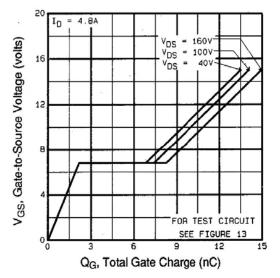


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

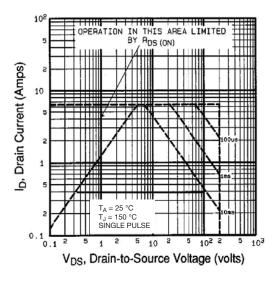


Fig. 8 - Maximum Safe Operating Area



5

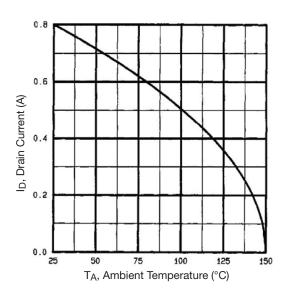


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

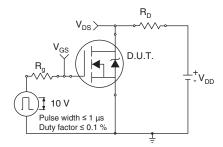


Fig. 10a - Switching Time Test Circuit

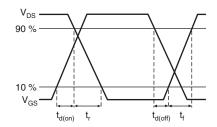


Fig. 10b - Switching Time Waveforms

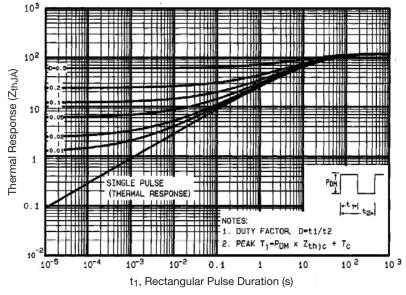


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



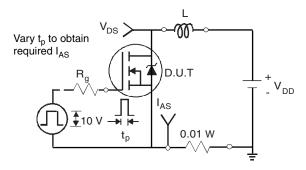


Fig. 12a - Unclamped Inductive Test Circuit

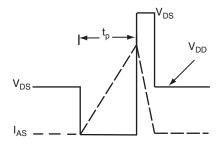


Fig. 12b - Unclamped Inductive Waveforms

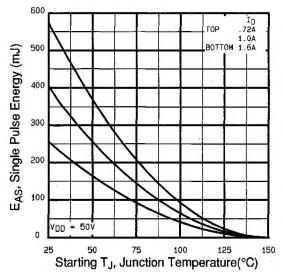


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

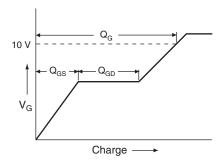


Fig. 13a - Basic Gate Charge Waveform

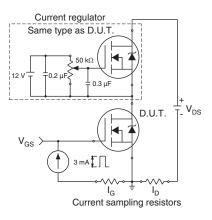
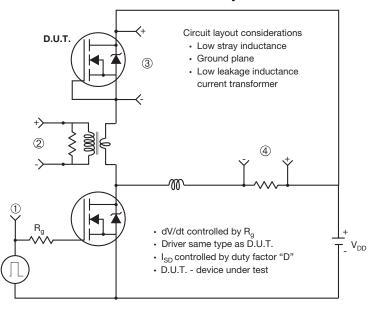


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



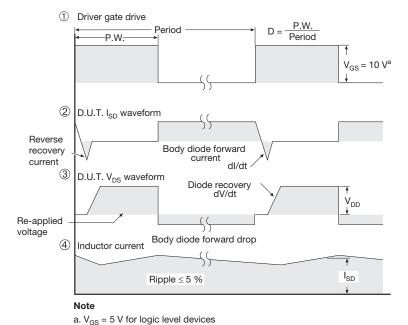
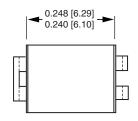
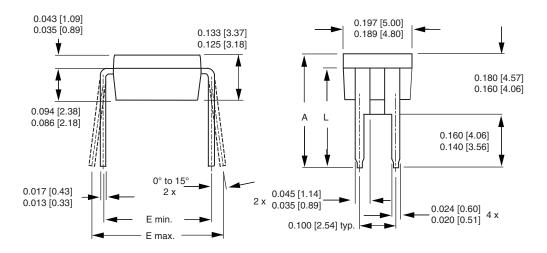


Fig. 14 - For N-Channel



HVM DIP (High voltage)





	INCHES		MILLIMETERS		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	0.310	0.330	7.87	8.38	
Е	0.300	0.425	7.62	10.79	
L	0.270	0.290	6.86	7.36	

ECN: X10-0386-Rev. B, 06-Sep-10

DWG: 5974

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.



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